

Notice of References Cited	Application/Control No. 10/567,355		Applicant(s)/Patent Under Reexamination MIYAZAKI ET AL.	
	Examiner /Susan W. Berman/		Art Unit 1796	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0202220	09-2006	Hayashi, Naoki	257/098
*	B	US-6,599,954	07-2003	Hayashi et al.	522/25
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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